

Application/Control No.	Applicant(s)/Patent under Reexamination
10/790,716 Examiner	TAKAHASHI ET AL.
John C. Douglas	1797

SEARCHED					
Class	Subclass	Date	Examiner		
585	15	11/19/2007	JCD		

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
	_				

SEARCH NO (INCLUDING SEARCH)
	DATE	EXMR
See Search History from EAST	11/19/2007	JCD